

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/928,361	TAKEBE, HIROAKI	
Examiner		Art Unit		Page 1 of 1
Mehrdad Dastouri		2623		

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	B	US-5,794,178	08-1998	Caid et al.	704/9
	C	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Lawrence et al., "Face Recognition Using Mixture-Distance and Raw Images", October 1997, IEEE International Conference on Simulation, Volume 3, Pages 2016-2021.
	V	Muller et al., "The Use of Eigenpictures for Optical Character Recognition", Proceedings, Fourteenth International Conference on Pattern Recognition, Volume 2, Pages 1124-1126.
	W	Peter Yianilos, "Metric Learning via Normal Mixtures", NEC Research Institute, 1995, 20 pages.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.